

# CoolSiC™ M1 CoolSiC™ MOSFET 650 V G1

The 650 V CoolSiC<sup>™</sup> is built over the solid silicon carbide technology developed in Infineon in more than 20 years. Leveraging the wide bandgap SiC material characteristics, the 650V CoolSiC<sup>™</sup> MOSFET offers a unique combination of performance, reliability and ease of use. Suitable for high temperature and harsh operations, it enables the simplified and cost effective deployment of the highest system efficiency.

# Tab Tab Tab Tab Tab

Drain

Tab

TOLL

#### **Features**

- Optimized switching behavior at higher currents
- Commutation robust fast body diode with low O<sub>f</sub>,
- Superior gate oxide reliability
- T<sub>i.max</sub>=175°C and excellent thermal behavior
- Lower  $R_{DS(on)}$  and pulse current dependency on temperature
- Increased avalanche capability
- Compatible with standard drivers
- Kelvin source provides up to 4 times lower switching losses

# Benefits

- · Unique combination of high performance, high reliability and ease of use
- · Ease of use and integration
- Suitable for topologies with continuous hard commutation
- Higher robustness and system reliability
- Efficiency improvement
- · Reduced system size leading to higher power density

## Potential applications

- SMPS
- UPS (uninterruptable power supplies)
- Solar PV inverters
- EV charging infrastructure
- Energy storage and battery formation
- Class D amplifiers

#### **Product validation**

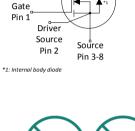
Fully qualified according to JEDEC for Industrial Applications

Please note: The source and sense source pins are not exchangeable. Their exchange might lead to malfunction.



Parameter	Value	Unit	
$V_{DS} @ T_J = 25 ^{\circ}\text{C}$	650	V	
$R_{DS(on),typ}$	39	mΩ	
R <sub>DS(on),max</sub>	51	mΩ	
$Q_{G,typ}$	41	nC	
I <sub>DM,max</sub>	122	А	
Q <sub>oss</sub> @ 400 V	97	nC	
<i>E<sub>oss</sub></i> @ 400 V	14.6	μЈ	

Type/Ordering Code	Package	Marking	Related Links
IMT65R039M1H	PG-HSOF-8	65R039M1	see Appendix A





#### Public

# CoolSiC™ MOSFET 650 V G1 IMT65R039M1H



# **Table of Contents**

Description	
Maximum ratings	
Thermal characteristics	
Operating range	5
Electrical characteristics	6
Electrical characteristics diagrams	8
Test Circuits	
Package Outlines	
Appendix A	
Revision History	
Trademarks	
Disclaimer	



# 1 Maximum ratings

at  $T_i = 25$  °C, unless otherwise specified.

Note: for optimum lifetime and reliability, Infineon recommends operating conditions that do not exceed 80% of the maximum ratings stated in this datasheet.

Table 2 Maximum ratings

Parameter	Values			S	Unit	Note / Took Condition	
raiaiiletei	Symbol	Min.	Тур.	Мах.	Onit	Note/ Test Condition	
Continuous DC drain current <sup>1)</sup>	I <sub>DDC</sub>	-	-	61 43	А	$T_c = 25 ^{\circ}\text{C}$ $T_c = 100 ^{\circ}\text{C}$	
Peak drain current <sup>2)</sup>	I <sub>DM</sub>	-	-	122	А	$T_{\rm c}$ = 25 °C, $V_{\rm GS}$ = 18 V	
Avalanche energy, single pulse	E <sub>AS</sub>	-	-	213	mJ	$I_{\rm D}$ = 8 A, $V_{\rm DD}$ = 50 V; see table 11	
Avalanche energy, repetitive	$E_{AR}$	-	-	1.06	mJ	$I_{\rm D} = 8 \text{ A}, V_{\rm DD} = 50 \text{ V}; \text{ see table } 11$	
Avalanche current, single pulse	I <sub>AS</sub>	-	-	8.0	Α	-	
MOSFET dv/dt ruggedness	dv/dt	-	-	200	V/ns	V <sub>DS</sub> = 0400 V	
Gate source voltage (static) 3)	$V_{GS}$	-5	-	23	V	-	
Gate source voltage (transient)	$V_{GS}$	-7	-	25	V	$t_{pulse} \le 1\%$ duty cycle/ $f_{sw}$	
Power dissipation	P <sub>tot</sub>	-	-	263	W	T <sub>c</sub> = 25 °C	
Storage temperature	$T_{\rm stg}$	-55	-	150	°C	-	
Operating junction temperature	T <sub>j</sub>	-55	-	175	°C	-	
Mounting torque	-	-	-	n.a.	Ncm	-	
Continuous reverse drain current <sup>1)</sup>	I <sub>SDC</sub>	-	-	61 35	А	$V_{GS} = 18 \text{ V}, T_c = 25 \text{ °C}$ $V_{GS} = 0 \text{ V}, T_c = 25 \text{ °C}$	
Peak reverse drain current <sup>2)</sup>	I <sub>SM</sub>	-	-	122	А	$T_{\rm c} = 25 {\rm ^{\circ}C},  t_{\rm p} \le 250 {\rm ns}$	
Insulation withstand voltage	V <sub>ISO</sub>	-	-	n.a.	V	$V_{\rm rms}$ , $T_{\rm c} = 25 {}^{\circ}{\rm C}$ , $t = 1 {\rm min}$	

<sup>1)</sup> Limited by  $T_{j,max}$ .

<sup>&</sup>lt;sup>2)</sup> Pulse width  $t_{\text{pulse}}$  limited by  $T_{\text{j,max}}$ .

<sup>3)</sup> The maximum gate-source voltage in the application design should be in accordance to IPC-9592B.



# 2 Thermal characteristics

#### Table 3 Thermal characteristics

Parameter	Symbol	Values			Unit	Note / Test Condition	
raiailletei	Syllibot	Min.	Тур.	Мах.	Oilit	Note/ Test Condition	
Thermal resistance, junction - case	$R_{th(j-c)}$	-	-	0.57	°C/W	-	
Thermal resistance, junction - ambient	$R_{th(j-a)}$	-	-	62	°C/W	device on PCB, minimal footprint	
Thermal resistance, junction - ambient, SMD version	$R_{ m th(j-a)}$	-	35	45	°C/W	Device on 40mm*40mm*1.5mm epoxy PCB FR4 with 6cm² (one layer, 70µm thickness) copper area for drain connection and cooling. PCB is vertical without air stream cooling.	
Soldering temperature, wave- & reflow soldering allowed	$T_{\rm sold}$	-	-	260	°C	reflow MSL2	



# 3 Operating range

Table 4 Operating range

Parameter	Symbol	Values			l lmit	Note / Test Condition
	Symbol	Min.	Тур.	Мах.	Unit	Note/ Test Condition
Gate-source voltage operating range including undershoots <sup>4)</sup>	$V_{GS}$	-2	-	20	V	-
Recommended turn-on voltage	$V_{GS(on)}$	-	18	-	V	-
Recommended turn-off voltage	$V_{GS(off)}$	-	0	-	V	-

4)

**Important notice:** If the gate source voltage of the device in application exceeds the operating range (Table 4), the device  $R_{DS,on}$  and  $V_{GS(th)}$  might exceed the maximum value stated in the datasheet at the end of the lifetime of the device. In order to ensure sound operation of the device over the planned lifetime, the maximum ratings (Table 2) and the CoolSiC<sup>TM</sup> MOSFET 650V M1 trench power device application note AN\_1907\_PL52\_1911\_144109 must be considered.



# 4 Electrical characteristics

at  $T_j$  = 25 °C, unless otherwise specified

Table 5 Static characteristics

Parameter	Symbol	Values			Unit	Note / Took Condition	
raiailletei	Symbol	Min.	Тур.	Мах.	Ollic	Note/ Test Condition	
Drain-source voltage	$V_{\rm DSS}$	650	-	-	V	$V_{\rm GS} = 0 \text{ V}, I_{\rm D} = 0.75 \text{ mA}$	
Gate threshold voltage <sup>5)</sup>	$V_{\rm GS(th)}$	3.5	4.5	5.7	V	$V_{\rm DS} = V_{\rm GS}, I_{\rm D} = 7.5 \rm mA$	
Zero gate voltage drain current	I <sub>DSS</sub>	-	1 3	100 -	μΑ	$V_{\rm DS} = 650 \text{ V}, V_{\rm GS} = 0 \text{ V}, T_{\rm j} = 25 \text{ °C}$ $V_{\rm DS} = 650 \text{ V}, V_{\rm GS} = 0 \text{ V}, T_{\rm j} = 175 \text{ °C}$	
Gate-source leakage current	$I_{GSS}$	-	-	100	nA	$V_{GS} = 20 \text{ V}, V_{DS} = 0 \text{ V}$	
Drain-source on-state resistance	R <sub>DS(on)</sub>	-	39 55	51 -	mΩ	$V_{GS} = 18 \text{ V}, I_D = 25 \text{ A}, T_j = 25 \text{ °C}$ $V_{GS} = 18 \text{ V}, I_D = 25 \text{ A}, T_j = 175 \text{ °C}$	
Internal gate resistance	$R_{G,int}$	-	5.0	-	Ω	f= 1 MHz	

<sup>5)</sup> Tested after 1 ms pulse at  $V_{GS}$  = +20 V.

Table 6 Dynamic characteristics

Parameter	Symbol	Values			Unit	Note/ Test Condition	
Parameter	Syllibol	Min.	Тур.	Мах.		rest condition	
Input capacitance	C <sub>iss</sub>	-	1393	-	pF	$V_{\rm GS} = 0 \text{ V}, V_{\rm DS} = 400 \text{ V}, f = 250 \text{ kHz}$	
Reverse transfer capacitance	$C_{\rm rss}$	-	15	-	pF	$V_{\rm GS} = 0 \text{ V}, V_{\rm DS} = 400 \text{ V}, f = 250 \text{ kHz}$	
Output capacitance <sup>6)</sup>	C <sub>oss</sub>	-	160	208	pF	$V_{GS} = 0 \text{ V}, V_{DS} = 400 \text{ V}, f = 250 \text{ kHz}$	
Output charge <sup>6)</sup>	$Q_{\rm oss}$	-	97	126	nC	calculation based on C <sub>oss</sub>	
Effective output capacitance, energy related <sup>7)</sup>	$C_{ m o(er)}$	-	182	-	pF	$V_{GS} = 0 \text{ V},$ $V_{DS} = 0400 \text{ V}$	
Effective output capacitance, time related <sup>8)</sup>	$C_{ m o(tr)}$	-	241	-	pF	$I_{\rm D}$ = constant, $V_{\rm GS}$ = 0 V, $V_{\rm DS}$ = 0400 V	
Turn-on delay time	$t_{ m d(on)}$	-	7.1	-	ns	$V_{\rm DD} = 400  \text{V}, \ V_{\rm GS} = 0/18  \text{V},$ $I_{\rm D} = 25  \text{A}, \ R_{\rm G,ext} = 1.8  \Omega;$ see table 10	
Rise time	t <sub>r</sub>	-	10.9	-	ns	$V_{\rm DD} = 400  \text{V}, \ V_{\rm GS} = 0/18  \text{V},$ $I_{\rm D} = 25  \text{A}, \ R_{\rm G,ext} = 1.8  \Omega;$ see table 10	
Turn-off delay time	$t_{ m d(off)}$	-	17	-	ns	$V_{\rm DD} = 400  \text{V}, \ V_{\rm GS} = 0/18  \text{V},$ $I_{\rm D} = 25  \text{A}, \ R_{\rm G,ext} = 1.8  \Omega;$ see table 10	
Fall time	t <sub>f</sub>	-	7.0	-	ns	$V_{\rm DD} = 400  \text{V}, \ V_{\rm GS} = 0/18  \text{V},$ $I_{\rm D} = 25  \text{A}, \ R_{\rm G,ext} = 1.8  \Omega;$ see table 10	

# CoolSiC™ MOSFET 650 V G1

#### IMT65R039M1H



#### Table 7 Gate charge characteristics

Parameter	Symbol	Values			Unit	Note/ Test Condition
Parameter	Syllibot	Min.	Тур.	Мах.	Offic	Note/ Test Condition
Plateau gate to source charge	$Q_{GS(pl)}$	-	11	-	nC	$V_{\rm DD} = 400 \text{V}, I_{\rm D} = 25 \text{A},$ $V_{\rm GS} = 0 \text{to} 18 \text{V}$
Gate to drain charge	$Q_{GD}$	-	9	-	nC	$V_{\rm DD} = 400 \text{V}, I_{\rm D} = 25 \text{A},$ $V_{\rm GS} = 0 \text{to}  18 \text{V}$
Total gate charge	$Q_{G}$	_	41	_	nC	$V_{\rm DD} = 400 \text{V}, I_{\rm D} = 25 \text{A},$ $V_{\rm GS} = 0 \text{to} 18 \text{V}$

#### Table 8 Reverse diode characteristics

Parameter	Symbol	Values			Unit	  Note/ Test Condition	
raianietei	Syllibot	Min.	Тур.	Max.	Offic	Hote, rest condition	
Drain-source reverse voltage	$V_{\rm SD}$	-	4.0	-	V	$V_{\rm GS} = 0 \text{ V}, I_{\rm S} = 25 \text{ A}, T_{\rm j} = 25 \text{ °C}$	
MOSFET forward recovery time	$t_{fr}$	-	21.2	-		$V_{DD} = 400 \text{ V}, I_{S} = 25 \text{ A},$ d $i_{S}$ /d $t = 1000 \text{ A/}\mu\text{s}$ ; see table 9	
MOSFET forward recovery charge <sup>9)</sup>	$Q_{fr}$	-	102	-	nC	$V_{DD} = 400 \text{ V}, I_{S} = 25 \text{ A},$ d $i_{S}$ /d $t = 1000 \text{ A/}\mu\text{s}$ ; see table 9	
MOSFET peak forward recovery current	I <sub>frm</sub>	-	8.3	-	А	$V_{DD} = 400 \text{ V}, I_{S} = 25 \text{ A},$ d $i_{S}$ /d $t = 1000 \text{ A/}\mu\text{s}$ ; see table 9	

<sup>9)</sup>  $Q_{fr}$  includes  $Q_{oss}$ .

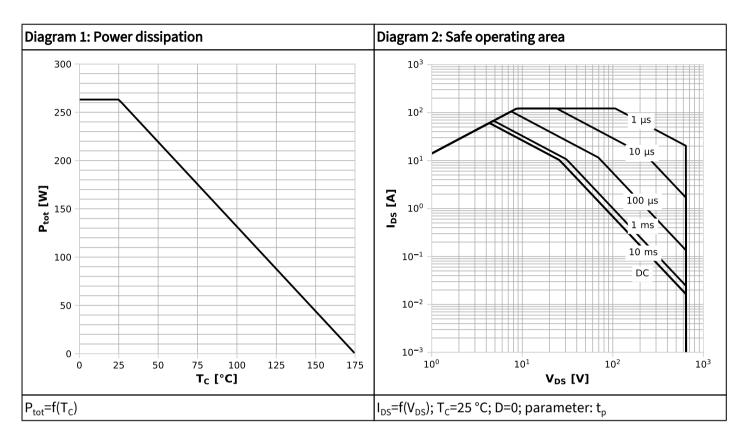
<sup>6)</sup> Maximum specification is defined by calculated six sigma upper confidence bound.

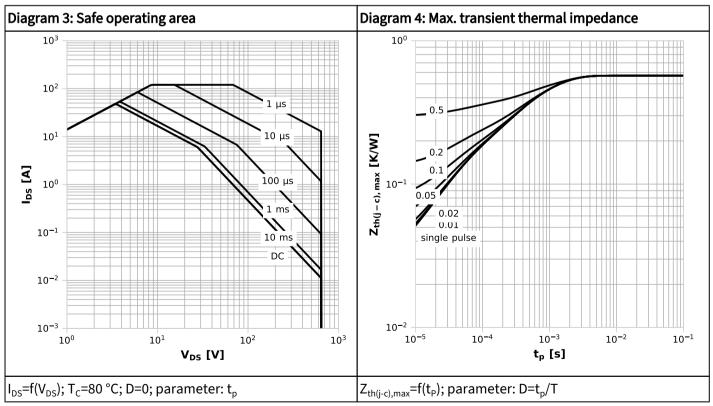
<sup>&</sup>lt;sup>7)</sup>  $C_{\text{o(er)}}$  is a fixed capacitance that gives the same stored energy as  $C_{\text{oss}}$  while  $V_{\text{DS}}$  is rising from 0 to 400 V.

<sup>8)</sup>  $C_{o(tr)}$  is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 400 V.

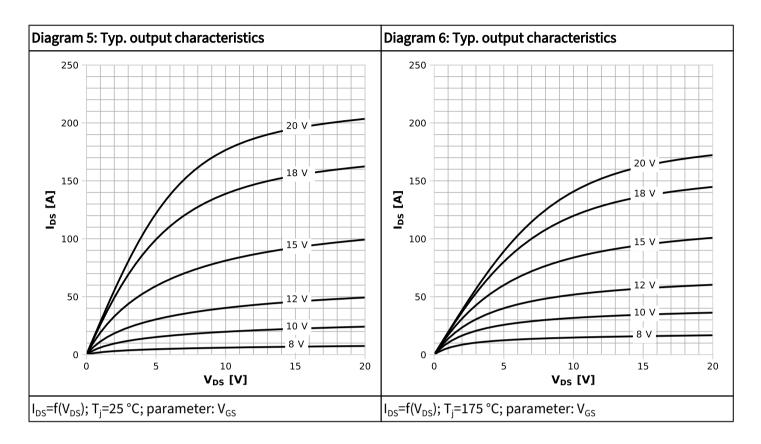


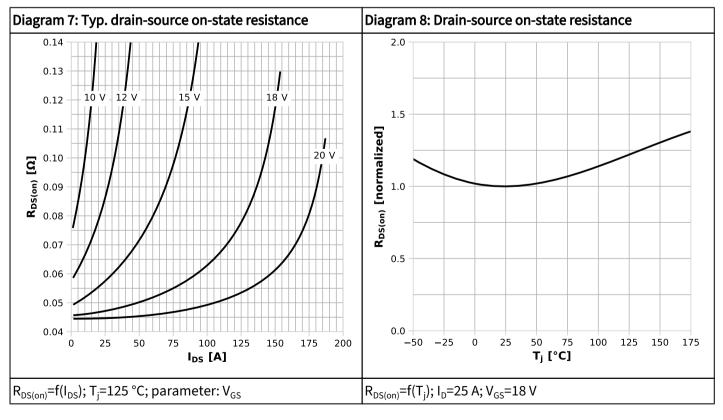
# 5 Electrical characteristics diagrams



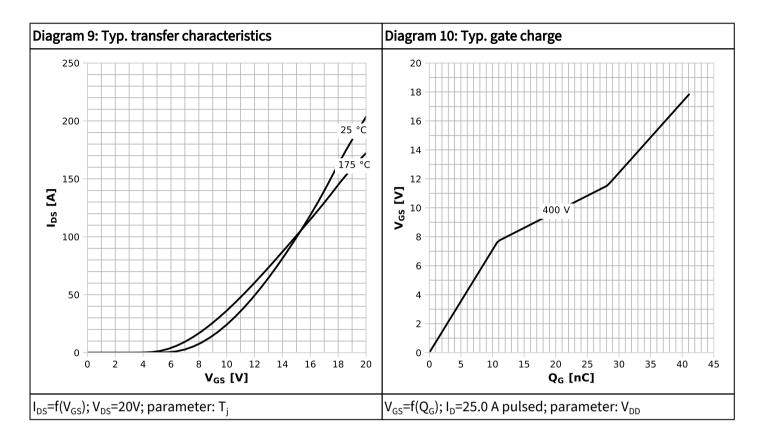


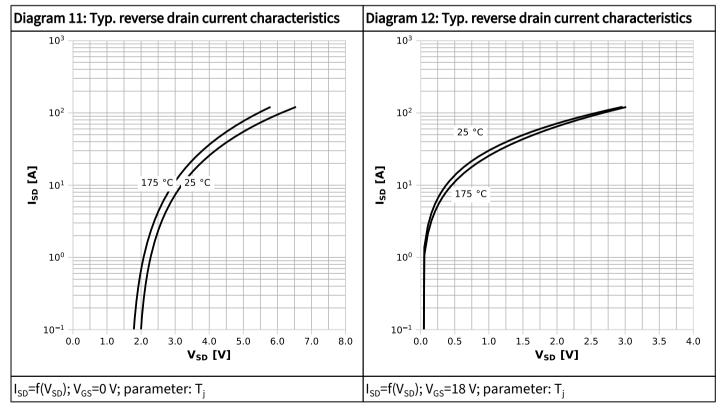




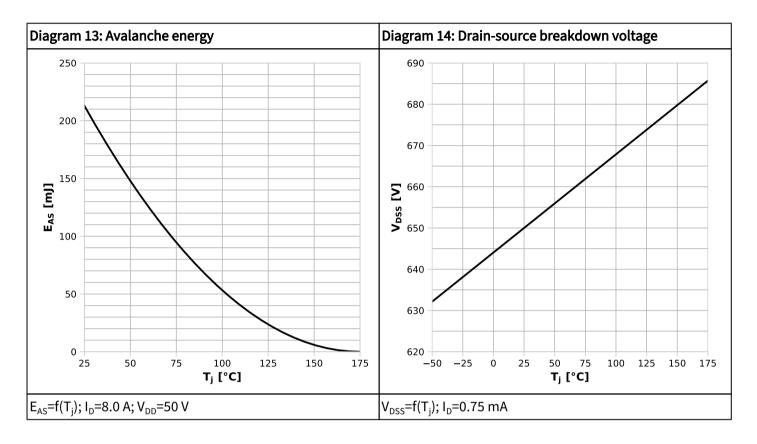


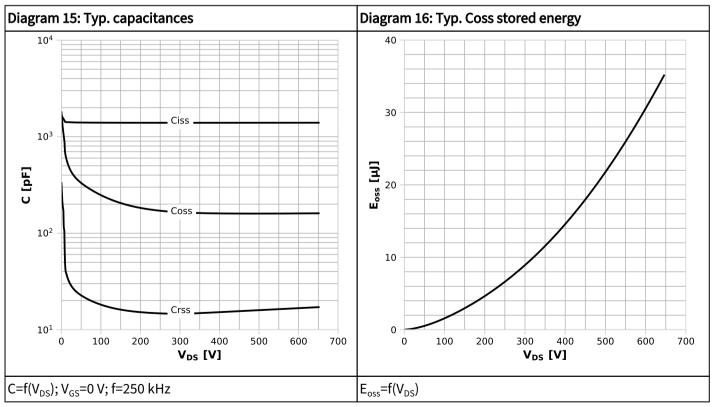




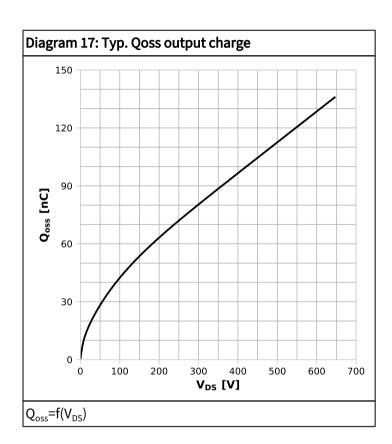














### 6 Test Circuits

Table 9 Body diode characteristics (CoolSiC)

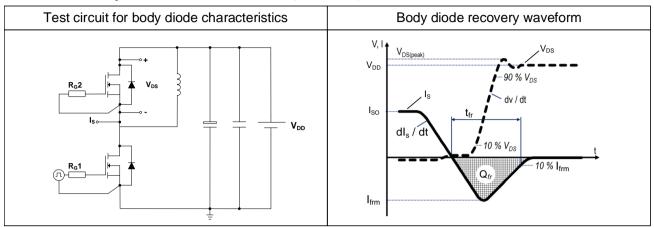


Table 10 Switching times (CoolSiC)

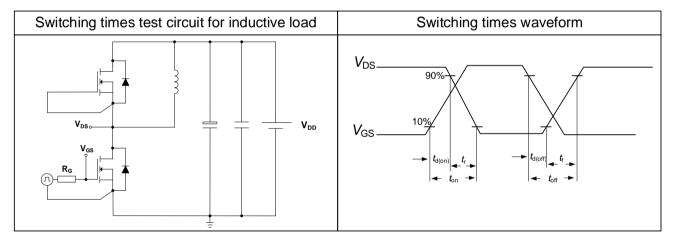
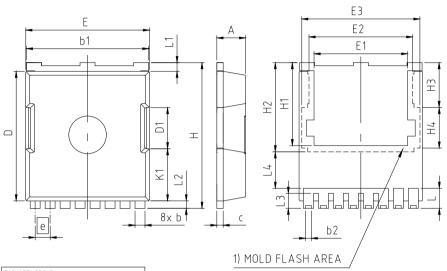


Table 11 Unclamped inductive load





# 7 Package Outlines



PACKAGE - GROUP NUMBER:	PG-HSOF-8-U02							
DIMENSIONS	MILLIM	ETERS						
DIMENSIONS	MIN.	MAX.						
Α	2.20	2.40						
b	0.70	0.90						
b1	9.70	9.90						
b2	0.42	0.50						
С	0.40	0.60						
D	10.28	10.58						
D1	3.	30						
E	9.70	10.10						
E1	7.50							
E2	8.	50						
E3	9.46							
е	1.20 (	BSC)						
Н	11.48	11.88						
H1	6.55	6.95						
H2	7.	15						
H3	3.	59						
H4	3.:	26						
N	8							
K1	4.18							
L	1.40	1.80						
L1	0.50	0.90						
L2	0.50	0.70						
L3	1.00	1.30						
L4	2.62	2.81						

1) PARTIALLY COVERED WITH MOLD FLASH

Figure 1 Outline PG-HSOF-8, dimensions in mm



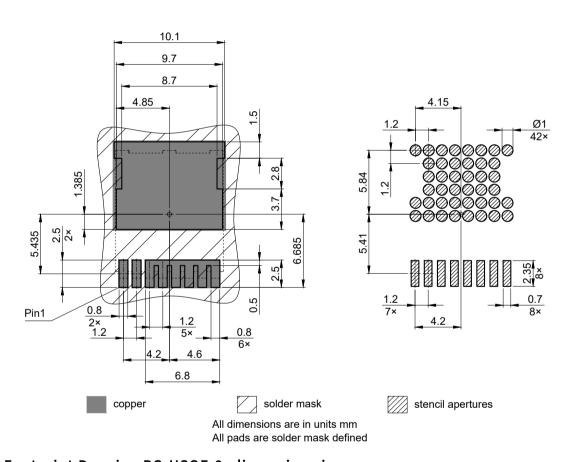


Figure 2 Footprint Drawing PG-HSOF-8, dimensions in mm



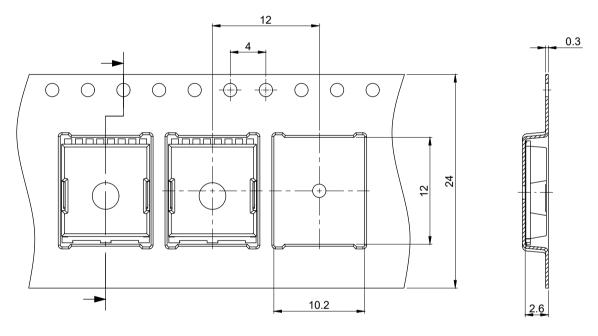


Figure 3 Packaging Variant PG-HSOF-8, dimensions in mm



# 8 Appendix A

#### Table 12 Related Links

- IFX CoolSiC CoolSiC™ MOSFET 650 V G1 Webpage
- IFX CoolSiC CoolSiC™ MOSFET 650 V G1 Application Note
- IFX CoolSiC CoolSiC™ MOSFET 650 V G1 Simulation Model
- IFX Design tools

# CoolSiC™ MOSFET 650 V G1



#### **Revision History**

IMT65R039M1H

#### Revision 2024-10-07, Rev. 2.3

#### **Previous Revision**

Revision	Date	Subjects (major changes since last revision)
2.0	2023-02-20	Release of final version
2.1	2023-02-24	Typo correction in footnote 1 page 4
2.2	2024-08-26	IDSS update, nomenclature update, datasheet layout and POD update
2.3	2024-10-07	Update with package footprint and outline drawing correction

#### **Trademarks**

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